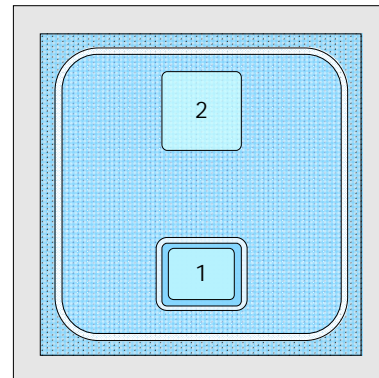


3VD045060JL N-channel MOSFET CHIPS
DESCRIPTION

- Ø 3VD045060JL is a N-Channel enhancement mode MOS-FET chip fabricated in advanced silicon epitaxial planar technology.
- Ø High density cell design for low $R_{DS(ON)}$
- Ø Rugged and reliable.
- Ø Fast switching performance.
- Ø High saturation current capability.
- Ø The chips may be packaged in SOT-23 type and the typical equivalent product is 2N7002.
- Ø The packaged product is widely used in the small servo motor control, power MOS-FET gate drivers, and other switching applications.
- Ø Die size: 0.53mm*0.53mm.



PAD1: GATE PAD2: SOURCE

CHIP TOPOGRAPHY

- Ø Chip Thickness: 230±20µm.
- Ø Top metal : Al, Backside Metal : Au.

ABSOLUTE MAXIMUM RATINGS (T_{amb}=25°C)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	60	V
Gate-Source Voltage	V _{GS}	±20	V
Drain Current	I _D	115	mA
Power Dissipation (SOT-23)	P _D	200	mW
Operation Junction Temperature	T _J	150	°C
Storage Temperature	T _{stg}	-55-150	°C

ELECTRICAL CHARACTERISTICS (T_{amb}=25°C)

Parameter	Symbol	Test conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =10µA	60			V
		V _{GS} =0V, I _D =3mA	60			
Gate-Threshold Voltage*	V _{th(GS)}	V _{DS} = V _{GS} , I _D =250µA	1		2.5	
Gate-body Leakage	I _{GSS}	V _{DS} =0V, V _{GS} =±20V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =60V, V _{GS} =0V			1	µA
On-state Drain Current*	I _{D(ON)}	V _{GS} =10V, V _{DS} =7V	500			mA
Drain-Source On-Resistance*	R _{DS(on)}	V _{GS} =10V, I _D =500mA		1.2	7.5	Ω
		V _{GS} =5V, I _D =50mA		1.7	7.5	
Drain-Source On- Voltage *	V _{DS(on)}	V _{GS} =10V, I _D =500mA			3.75	V
		V _{GS} =5V, I _D =50mA			0.375	
Forward Transconductance*	g _{ts}	V _{DS} =10V, I _D =200mA	80			ms
Diode Forward Voltage	V _{SDF}	I _S =115mA, V _{GS} =0V			1.2	V

Note:* Pulse test, pulse width≤300µS, duty cycles≤2%